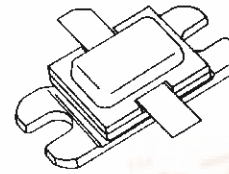




AM1214-175

RF & MICROWAVE TRANSISTORS L-BAND RADAR APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- 3:1 VSWR CAPABILITY
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- $P_{OUT} = 160\text{ W MIN. WITH } 7.3\text{ dB GAIN}$



.400 x .500 2LFL (S038)
hermetically sealed

ORDER CODE
AM1214-175

BRANDING
1214-175

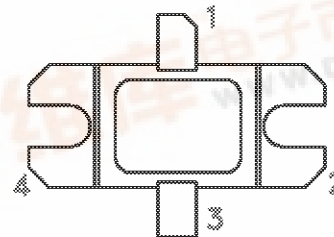
DESCRIPTION

The AM1214-175 device is a high power Class C transistor specifically designed for L-Band radar pulsed output and driver applications.

This device is capable of operation over a wide range of pulse widths, duty cycles and temperatures and is capable of withstanding 3:1 output VSWR at rated RF conditions. Low RF thermal resistance and computerized automatic wire bonding techniques ensure high reliability and product consistency.

The AM1214-175 is supplied in the BIGPAC™ Hermetic Metal/Ceramic package with internal Input/Output matching structures.

PIN CONNECTION



- | | |
|--------------|------------|
| 1. Collector | 3. Emitter |
| 2. Base | 4. Base |

ABSOLUTE MAXIMUM RATINGS ($T_{case} = 25^{\circ}\text{C}$)

Symbol	Parameter	Value	Unit
P_{DISS}	Power Dissipation* ($T_c \leq 100^{\circ}\text{C}$)	330	W
I_c	Device Current*	14	A
V_{CC}	Collector-Supply Voltage*	45	V
T_J	Junction Temperature (Pulsed RF Operation)	250	$^{\circ}\text{C}$
T_{STG}	Storage Temperature	- 65 to +200	$^{\circ}\text{C}$

THERMAL DATA

$R_{TH(j-c)}$	Junction-Case Thermal Resistance*	0.45	$^{\circ}\text{C/W}$
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*Applies only to rated RF amplifier operation

AM1214-175

ELECTRICAL SPECIFICATIONS ($T_{\text{case}} = 25^{\circ}\text{C}$)

STATIC

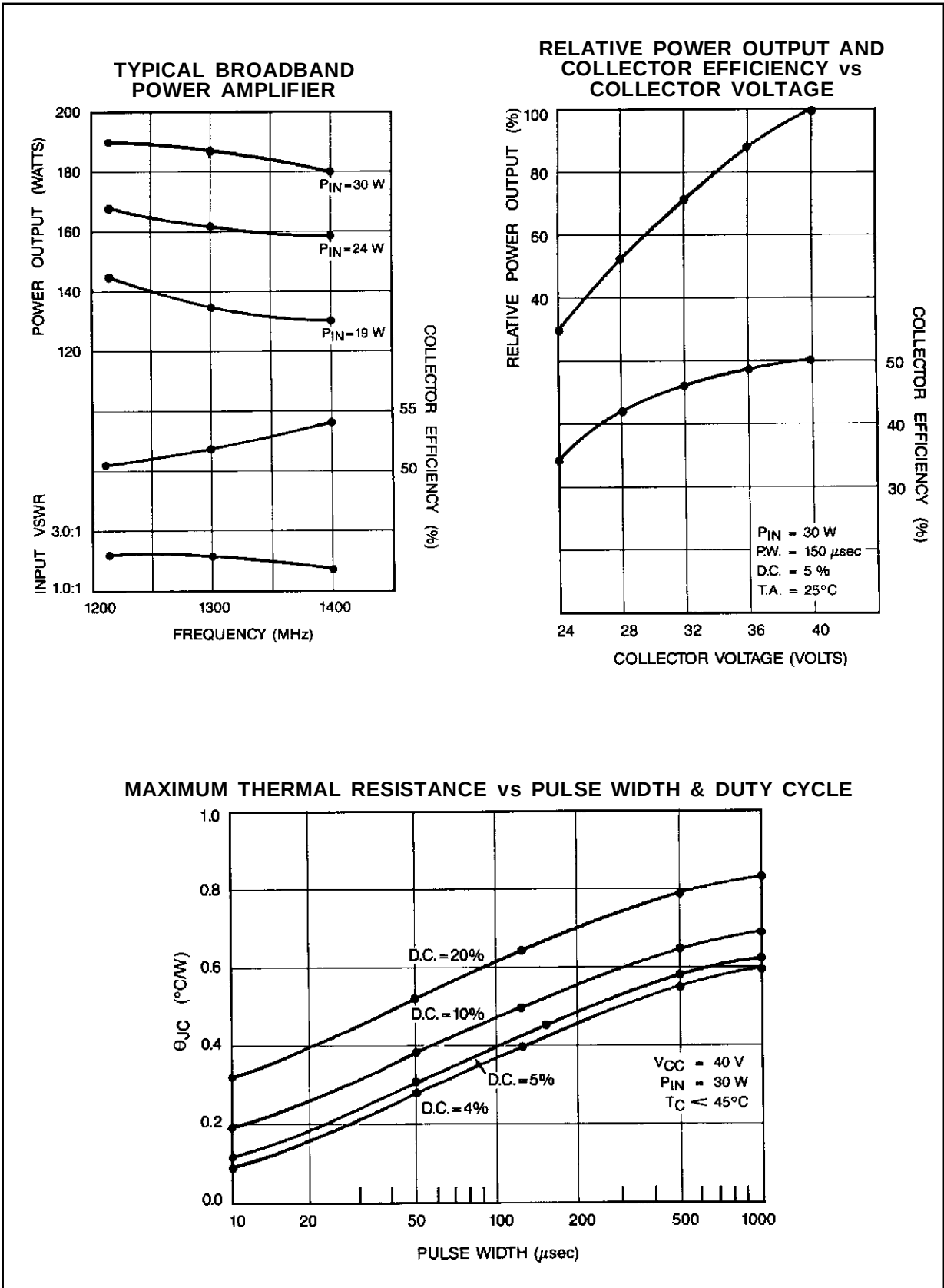
Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
BV_{CBO}	$I_{\text{C}} = 60\text{mA}$ $I_{\text{E}} = 0\text{mA}$	65	—	—	V
BV_{EBO}	$I_{\text{E}} = 10\text{mA}$ $I_{\text{C}} = 0\text{mA}$	3.5	—	—	V
BV_{CES}	$I_{\text{C}} = 100\text{mA}$	65	—	—	V
I_{CES}	$V_{\text{CE}} = 40\text{V}$	—	—	25	mA
h_{FE}	$V_{\text{CE}} = 5\text{V}$ $I_{\text{C}} = 5\text{A}$	15	—	150	—

DYNAMIC

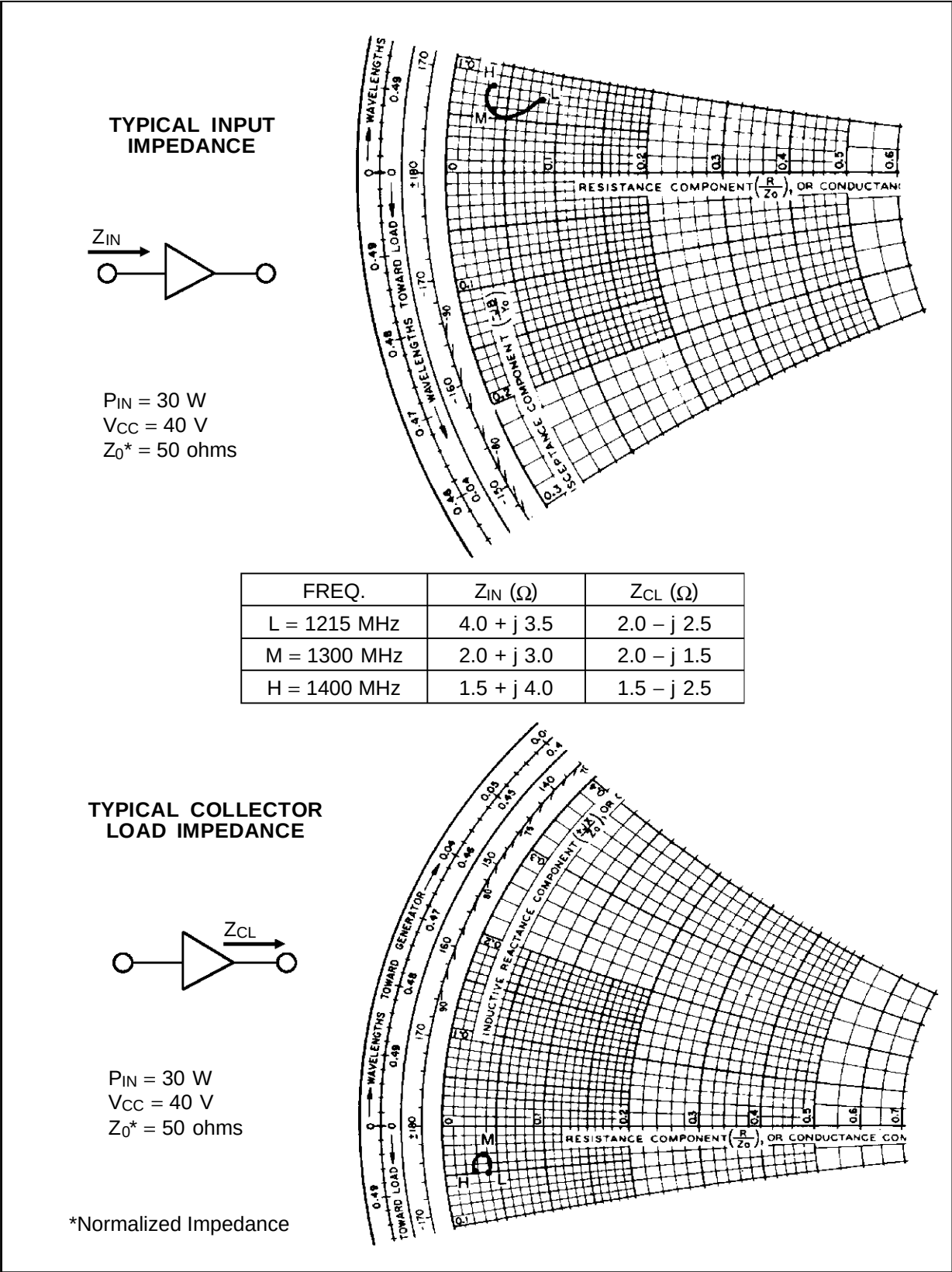
Symbol	Test Conditions	Value			Unit
		Min.	Typ.	Max.	
P_{OUT}	$f = 1215 - 1400\text{MHz}$ $P_{\text{IN}} = 30\text{W}$ $V_{\text{CC}} = 40\text{V}$	160	180	—	W
η_{c}	$f = 1215 - 1400\text{MHz}$ $P_{\text{IN}} = 30\text{W}$ $V_{\text{CC}} = 40\text{V}$	45	50	—	%
G_{P}	$f = 1215 - 1400\text{MHz}$ $P_{\text{IN}} = 30\text{W}$ $V_{\text{CC}} = 40\text{V}$	7.3	7.8	—	dB

Note: Pulse Width = $150\mu\text{S}$
 Duty Cycle = 5%

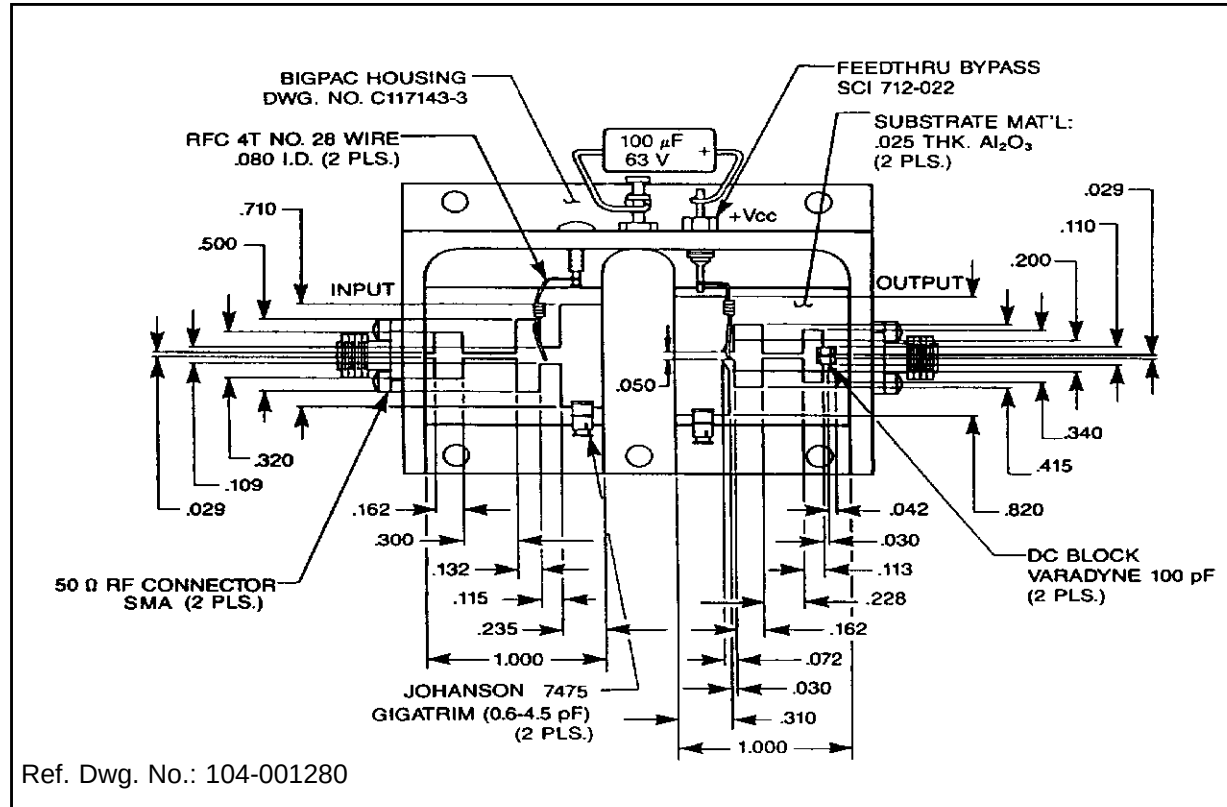
TYPICAL PERFORMANCE



IMPEDANCE DATA

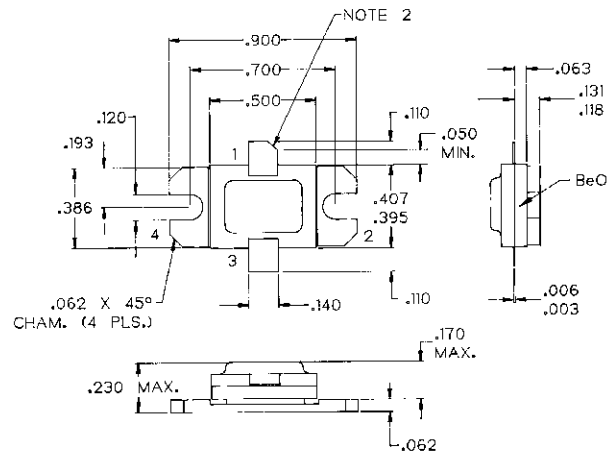


TEST CIRCUIT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.: J135066F



NOTES:

1. ALL TOLERANCE $\pm .010$ EXCEPT WHERE NOTED;
DIMENSIONS IN INCHES.
2. COLLECTOR LEAD CHAMFER 45° NOM. X .040 NOM.

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